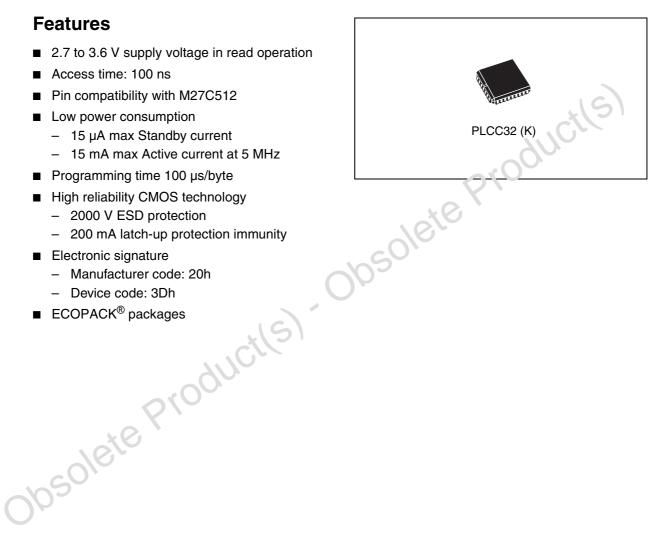




## 512 Kbit (64 Kbit x8) low-voltage OTP EPROM

#### **Features**

- 2.7 to 3.6 V supply voltage in read operation
- Access time: 100 ns
- Pin compatibility with M27C512
- Low power consumption
  - 15 μA max Standby current
  - 15 mA max Active current at 5 MHz



Contents M27W512

## **Contents**

1	Desc	cription	5
2	Devi	ice operation	7
	2.1	Read mode	7
	2.2	Standby mode	7
	2.3	Two line output control	
	2.4	System considerations	8
	2.5	System considerations	9
	2.6	PRESTO IIB programming algorithm	. 10
	2.7	Program inhibit	. 10
	2.8	Program verify	. 10
	2.9	Programming  PRESTO IIB programming algorithm  Program inhibit  Program verify  Electronic signature	. 10
3	Maxi	imum rating	. 11
4	DC a	and AC parameters	. 12
5	Pack	kage mechanical data	. 18
6	Part	numbering	. 20
7	<b>R</b> wi	ision history	21

M27W512 List of tables

## List of tables

Table 1.	Signal names	. 6
Table 2.	Flectronic signature	. 7
Table 4.	Absolute maximum ratings	11
Table 5.	AC measurement conditions	12
Table 6.	Capacitance	13
Table 7.	Read mode DC characteristics	13
Table 8.	Read mode AC characteristics	14
Table 9.	Programming mode DC characteristics	15
Table 10.	Margin mode AC characteristics	15
Table 11.	Programming mode AC characteristics	16
Table 12.	Ordering information schome	20
Table 13. Table 14	Document revision history	21
	Signal names Operating modes Electronic signature Absolute maximum ratings AC measurement conditions Capacitance Read mode DC characteristics Read mode AC characteristics Programming mode DC characteristics Margin mode AC characteristics Programming mode AC characteristics Programming mode AC characteristics PlcC32 - 32 lead plastic leaded chip carrier, package mechanical data. Ordering information scheme Document revision history	
Obsoli	ate Pros	

List of figures M27W512

# **List of figures**

Figure 1. Figure 2. Figure 3. Figure 4. Figure 5. Figure 6. Figure 7. Figure 8.	Logic diagram  LCC connections  Programming flowchart  AC testing input output waveform  AC testing load circuit  Read mode AC waveforms  Margin mode AC waveforms  1 Programming and verify mode AC waveforms  1
Figure 9.	PLCC32 - 32 lead plastic leaded chip carrier, package outline
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M27W512 Description

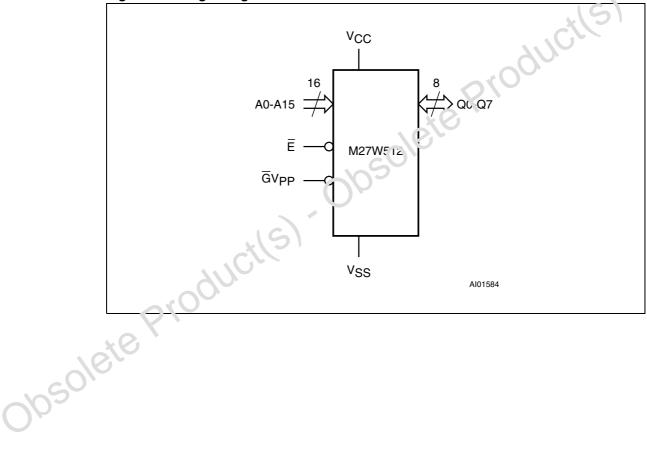
## 1 Description

The M27W512 is a low-voltage, 512 Kbit OTP (one-time programmable) EPROM. It is ideally suited to microprocessor systems and are organized as 65536 by 8 bits.

The M27W512 operates in the read mode with a supply voltage as low as 2.7 V at -40 to 85 °C temperature range. The decrease in operating power allows either a reduction of the size of the battery or an increase in the time between battery recharges.

For applications where the content is programmed only one time and erasure is not required, the M27W512 is offered in PLCC32 packages.

Figure 1. Logic diagram

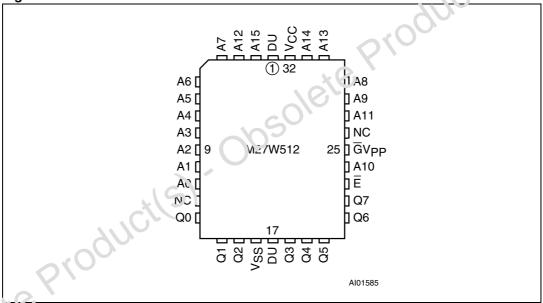


Description M27W512

Table 1. Signal names

Signal names	Function			
A0-A15	Address inputs			
Q0-Q7	Data outputs			
Ē	Chip Enable			
GV <sub>PP</sub>	Output Enable / Program supply			
V <sub>CC</sub>	Supply voltage			
V <sub>SS</sub>	Ground			
NC	Not connected internally			
DU	Don't use			

Figure 2. LCC connections



M27W512 **Device operation** 

#### **Device operation** 2

The modes of operations of the M27W512 are listed in Table 2: Operating modes. A single power supply is required in the read mode. All inputs are TTL levels except for  $\overline{G}V_{PP}$  and 12V on A9 for Electronic Signature.

#### 2.1 Read mode

The M27W512 has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable (E) is the power control and should be used for device selection. Output Enable (G) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that the addresses are stable, the address access time ( $t_{AVQV}$ ) is equal to the delay from E to output ( $t_{ELQV}$ ) at a is available at the output after a delay of  $t_{GLOV}$  from the falling edge of  $\overline{G}$ , assuming that  $\overline{E}$  has been low and the addresses have been stable for at least  $t_{AVQV}$ - $t_{GLQV}$ -

#### 2.2 Standby mode

The M27W512 has a standby mode which reduces the supply current from 15mA to 15µA with low voltage operation  $V_{CC} \le 3.6V$ , see *Table in Read mode DC characteristics*.

Characteristics table for details. The M27 1/512 is placed in the standby mode by applying a CMOS high signal to the E input. When it the standby mode, the outputs are in a high impedance state, independent of the Gvpp input.

Table 2. Operating modes (1)

	Mode	Ē	<b>G</b> V <sub>PP</sub>	A9	Q7-Q0
	Read	$V_{IL}$	$V_{IL}$	Х	Data Out
	Output Disable	V <sub>IL</sub>	V <sub>IH</sub>	Х	Hi-Z
	Program.	V <sub>IL</sub> Pulse	V <sub>PP</sub>	Х	Data In
\(	F`rogram Inhibit	V <sub>IH</sub>	V <sub>PP</sub>	Х	Hi-Z
c0//	Standby	V <sub>IH</sub>	Х	Х	Hi-Z
71050	Electronic Signature	$V_{IL}$	V <sub>IL</sub>	V <sub>ID</sub>	Codes
<b>)</b> •	1. $X = V_{IH}$ or $V_{IL}$ , $V_{ID} = 12V \pm 0.5V$ .	•	•		•

<sup>1.</sup>  $X = V_{IH}$  or  $V_{IL}$ ,  $V_{ID} = 12V \pm 0.5V$ .

Table 3. **Electronic signature** 

Identifier	Α0	<b>Q</b> 7	Q6	Q5	Q4	Q3	Q2	Q1	Q0	Hex data
Manufacturer code	$V_{IL}$	0	0	1	0	0	0	0	0	20h
Device code	$V_{IH}$	0	0	1	1	1	1	0	1	3Dh

Device operation M27W512

### 2.3 Two line output control

Because EPROMs are usually used in larger memory arrays, the product features a 2 line control function which accommodates the use of multiple memory connection. The two line control function allows:

- The lowest possible memory power dissipation
- Complete assurance that output bus contention will not occur.

For the most efficient use of these two control lines,  $\overline{E}$  should be decoded and used as the primary device selecting function, while  $\overline{G}$  should be made a common connection to all devices in the array and connected to the  $\overline{READ}$  line from the system control bus. This ensures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is required from a particular memory device.

### 2.4 System considerations

The power switching characteristics of Advanced CMOS EPROMs require careful decoupling of the devices. The supply current, I<sub>CC</sub>, has three segments that are of interest to the system designer: the standby current level, the active current level, and transient current peaks that are produced by the falling and rising edges of  $\overline{\mathbf{r}}$ . The magnitude of the transient current peaks is dependent on the capacitive and inductive loading of the device at the output.

The associated transient voltage peaks can be suppressed by complying with the two line output control and by properly selected a scrupling capacitors. It is recommended that a 0.1 $\mu$ F ceramic capacitor be used on every device between V<sub>CC</sub> and V<sub>SS</sub>. This should be a high frequency capacitor of low inherent inductance and should be placed as close to the device as possible. In addition, a 4.7 $\mu$ F bulk electrolytic capacitor should be used between V<sub>CC</sub> and V<sub>SS</sub> for every exquit devices. The bulk capacitor should be located near the power supply connection point. The purpose of the bulk capacitor is to overcome the voltage drop caused by the inductive effects of PCB traces.

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M27W512 Device operation

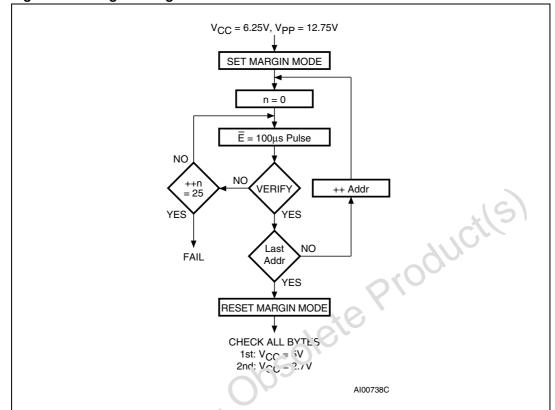


Figure 3. Programming flowchart

### 2.5 Programming

The M27W512 has been designed to be fully compatible with the M27C512 and has the same electronic signature. As a result, the M27W512 can be programmed as the M27C512 on the same programming equipment applying 12.75V on  $V_{PP}$  and 6.25V on  $V_{CC}$ . The M27W512 can use PRESTO IIB Programming Algorithm that drastically reduces the programming time. Nevertheless to achieve compatibility with all programming equipment, PRESTO II Programming Algorithm can be used as well. When delivered, all bits of the M27W512 are in the '1' state. Data is introduced by selectively programming '0's into the desired bit locations. Although only '0's will be programmed, both '1's and '0's can be present in the data word. The M27W512 is in the programming mode when  $V_{PP}$  input is at 12.75V and  $\overline{E}$  is pulsed to  $V_{IL}$ . The data to be programmed is applied to 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.  $V_{CC}$  is specified to be 6.25V  $\pm$  0.25V.

Device operation M27W512

### 2.6 PRESTO IIB programming algorithm

PRESTO IIB programming algorithm allows the whole array to be programmed with a guaranteed margin, in a typical time of 6.5 seconds. This can be achieved with STMicroelectronics M27W512 due to several design innovations described in the M27W512 datasheet to improve programming efficiency and to provide adequate margin for reliability. Before starting the programming the internal MARGIN MODE circuit must be set in order to guarantee that each cell is programmed with enough margin. Then a sequence of 100µs program pulses is applied to each byte until a correct verify occurs (see *Figure 3*). No overprogram pulses are applied since the verify in MARGIN MODE at V<sub>CC</sub> much higher than 3.6V, provides the necessary margin.

### 2.7 Program inhibit

Programming of multiple devices in parallel with different data is also easily accumplished. Except for  $\overline{E}$ , all like inputs including  $\overline{GV_{PP}}$  of the parallel M27W512 may be common. A TTL low level pulse applied to a M27W512  $\overline{E}$  input, with  $V_{PP}$  at 12.75V, will program this device. A high level  $\overline{E}$  input inhibits the other M27W512 from being programmed.

### 2.8 Program verify

A verify (read) should be performed on the programmed bits to determine that they were correctly programmed. The verify is accomplished with  $\overline{G}$  at  $V_{IL}$ . Data should be verified with  $t_{ELOV}$  after the falling edge of  $\overline{E}$ .

### 2.9 Electronic signature

The Electronic Signature (ES) mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment to automatically match the device to be programmed with its corresponding programming algorithm. The ES mode is functional in the 25°C  $\pm$  5°C ambient temperature range that is required when programming the M27W512. To activate the ES mode, the programming equipment must force 11.5V to 12.5V on address line A9 of the M27W512. Two identifier bytes may then be sequenced from the device outputs by toggling address line A0 from  $V_{IL}$  to  $V_{IH}$ . All other address lines must be held at  $V_{IL}$  during Electronic Signature mode. Byte 0 (A0 =  $V_{IL}$ ) represents the manufacturer code and byte 1 (A0 =  $V_{IH}$ ) the device identifier code. For the STMicroelectronics M27W512, these two identifier bytes are given in *Table 3* and can be read-out on outputs Q7 to Q0.

Note that the M27W512 and M27C512 have the same identifier byte.

M27W512 Maximum rating

#### **Maximum rating** 3

Stressing the device outside the ratings listed in Table 4 may cause permanent damage to the device. These are stress ratings only, and operation of the device at these, or any other conditions outside those indicated in the operating sections of this specification, is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Refer also to the STMicroelectronics SURE Program and other relevant quality documents.

Table 4. **Absolute maximum ratings** 

Symbol	Parameter	Value	Unit
T <sub>A</sub>	Ambient operating temperature <sup>(1)</sup>	-40 to 125	S°C
T <sub>BIAS</sub>	Temperature under bias	–50 to 125	°C
T <sub>STG</sub>	Storage temperature	-60 to 150	°C
V <sub>IO</sub> <sup>(2)</sup>	Input or output voltage (except A9)	-2 to 7	V
V <sub>CC</sub>	Supply voltage	–2 to 7	V
V <sub>A9</sub> <sup>(2)</sup>	A9 voltage	–2 to 13.5	V
V <sub>PP</sub>	Program supply voltage	–2 to 14	V

<sup>1.</sup> Depends on range.

Minimum DC voltage on input or output is -0.5 V vita possible undershoot to -2.0 V for a period less than 20ns. Maximum DC voltage on Output is  $V_{\text{CC}} + J.5 \text{V}$  with possible overshoot to  $V_{\text{CC}} + 2 \text{V}$  for a period less than 20ns. Josolete Producils

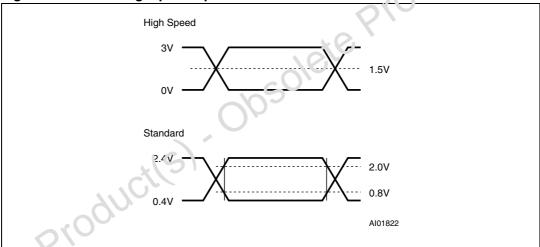
## 4 DC and AC parameters

This section summarizes the operating and measurement conditions, and the DC and AC characteristics of the device. The parameters in the DC and AC Characteristic tables that follow are derived from tests performed under the Measurement Conditions summarized in the relevant tables. Designers should check that the operating conditions in their circuit match the measurement conditions when relying on the quoted parameters.

Table 5. AC measurement conditions

	High speed	Standard
Input rise and fall times	≤10ns	<b>⊴</b> 0ns
Input pulse voltages	0 to 3V	0.4V to 2.4V
Input and output timing ref. voltages	1.5V	V≤ t/nr ∨8.0

Figure 4. AC testing input output waveform



rigure 5. AC testing load circuit

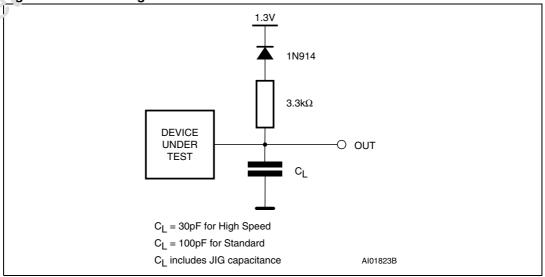


Table 6. Capacitance

Symbol	Parameter	Test condition <sup>(1)(2)</sup>	Min	Max	Unit
C <sub>IN</sub>	Input capacitance	$V_{IN} = 0V$		6	pF
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0V		12	pF

<sup>1.</sup>  $T_A = 25^{\circ}C$ , f = 1MHz

Table 7. Read mode DC characteristics

Symbol	Parameter	Test condition <sup>(1)</sup>	Min	Max	Unit
I <sub>LI</sub>	Input leakage current	0V ≤V <sub>IN</sub> ≤V <sub>CC</sub>		±10	μΑ
I <sub>LO</sub>	Output leakage current	0V ≤V <sub>OUT</sub> ≤V <sub>CC</sub>		±10	μA
I <sub>CC</sub>	Supply current	$\overline{E} = V_{IL}, \overline{G} = V_{IL},$ $I_{OUT} = 0mA, f = 5MHz$ $V_{CC} \leq 3.6V$	00	iə	mA
I <sub>CC1</sub>	Supply current (Standby) TTL	E = V <sub>IH</sub>	010	1	mA
I <sub>CC2</sub>	Supply current (Standby) CMOS	$\overline{E}$ > $V_{CC}$ - 0.2V, $V_{CC} \le 3.6V$		15	μΑ
I <sub>PP</sub>	Program current	$V_{PP} = V_{CC}$		10	μΑ
V <sub>IL</sub>	Input low voltage	0/02	-0.6	0.2 V <sub>CC</sub>	٧
V <sub>IH</sub> <sup>(2)</sup>	Input high voltage	0,4	0.7 V <sub>CC</sub>	V <sub>CC</sub> + 0.5	V
V <sub>OL</sub>	Output low voltage	I <sub>OL</sub> = 2.1mA		0.4	V
V <sub>OH</sub>	Output high voltage TTL	I <sub>OH</sub> = −1mA	2.4		٧

<sup>1.</sup>  $V_{CC}$  must be applied simultaneously with cribefore  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ .

<sup>2.</sup> Sampled only, not 100% tested.

<sup>2.</sup> Maximum DC voltage on Outpu'. is  $V_{CC}$  +0.5V.

Table 8. Read mode AC characteristics

		Alt Parameter		M27W512						
			Test	-70	70 <sup>(2)</sup> -8		-80 <sup>(2)</sup>		00	
Symbol	Alt		condition (1)	V <sub>CC</sub> = 3.0 to 3.6V		V <sub>CC</sub> = 2.7 to 3.6V		V <sub>CC</sub> = 2.7 to 3.6V		Unit
				Min	Max	Min	Max	Min	Max	
t <sub>AVQV</sub>	t <sub>ACC</sub>	Address valid to output valid	$\overline{E} = V_{IL},$ $\overline{G} = V_{IL}$		70		80		100	ns
t <sub>ELQV</sub>	t <sub>CE</sub>	Chip Enable low to output valid	$\overline{G} = V_{IL}$		70		80		100	ns
t <sub>GLQV</sub>	t <sub>OE</sub>	Output Enable low to output valid	$\overline{E} = V_IL$		40		50	(	૧૦	ns
t <sub>EHQZ</sub> (3)	t <sub>DF</sub>	Chip Enable high to output Hi-Z	G = V <sub>IL</sub>	0	40	0	50	900	60	ns
t <sub>GHQZ</sub> (3)	t <sub>DF</sub>	Output Enable high to output Hi-Z	$\overline{E} = V_IL$	0	40	0	50		60	ns
t <sub>AXQX</sub>	t <sub>ОН</sub>	Address transition to output transition	$\overline{\overline{E}} = V_{IL},$ $\overline{G} = V_{IL}$	0	9/6	0				ns

- 1.  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ .
- 2. Speed obtained with High Speed AC measurement conditions.
- 3. Sampled only, not 100% tested.

Figure 6. Read mode AC waveforing

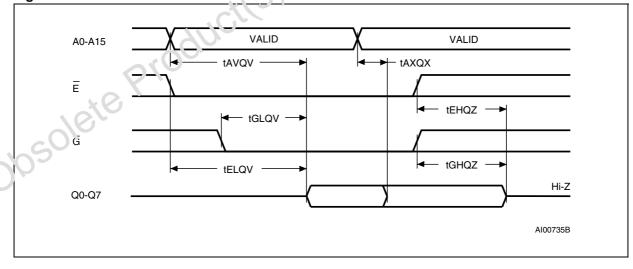


Table 9. **Programming mode DC characteristics** 

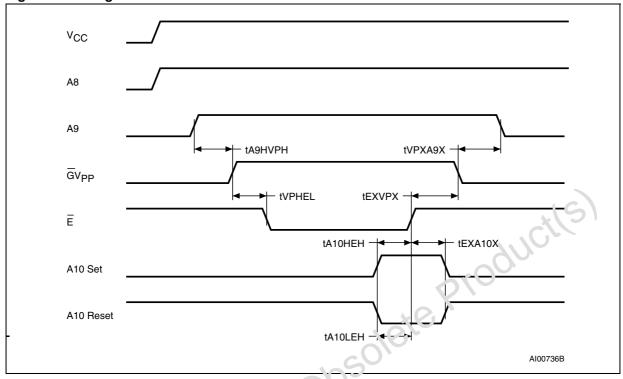
Symbol	Parameter	Test condition <sup>(1)(2)</sup>	Min	Max	Unit
I <sub>LI</sub>	Input leakage current	$V_{IL} \leq V_{IN} \leq V_{IH}$		±10	μΑ
I <sub>cc</sub>	Supply current			50	mA
I <sub>PP</sub>	Program current	$\overline{E} = V_{IL}$		50	mA
V <sub>IL</sub>	Input low voltage		-0.3	0.8	V
V <sub>IH</sub>	Input high voltage		2	V <sub>CC</sub> + 0.5	V
V <sub>OL</sub>	Output low voltage	I <sub>OL</sub> = 2.1mA		0.4	V
V <sub>OH</sub>	Output high voltage TTL	$I_{OH} = -1mA$	3.6		V
V <sub>ID</sub>	A9 voltage		11.5	12.5	CV

Table 10. Margin mode AC characteristics								
Symbol	Alt	Parameter Test condition <sup>(1, (2)</sup>		Min	Max	Unit		
t <sub>A9HVPH</sub>	t <sub>AS9</sub>	V <sub>A9</sub> high to V <sub>PP</sub> high	2		μs			
t <sub>VPHEL</sub>	t <sub>VPS</sub>	V <sub>PP</sub> high to Chip Enable low		2		μs		
t <sub>A10HEH</sub>	t <sub>AS10</sub>	V <sub>A10</sub> high to Chip Enable high (set)	10 high to Chip Enable high (set)			μs		
t <sub>A10LEH</sub>	t <sub>AS10</sub>	V <sub>A10</sub> low to Chip Enable high (reset)			μs			
t <sub>EXA10X</sub>	t <sub>AH10</sub>	Chip Enable transition to V <sub>A10</sub> transition			μs			
t <sub>EXVPX</sub>	t <sub>VPH</sub>	Chip Enable transition: to V >P transition		2		μs		
t <sub>VPXA9X</sub>	t <sub>AH9</sub>	V <sub>PP</sub> transition o V <sub>A9</sub> transition		2		μs		

<sup>1.</sup>  $T_A = 25$  °C;  $V_{CC} = 6.25V \pm 0.25$  v;  $V_{Fr} = 12.75V \pm 0.25V$ 

<sup>2.</sup>  $V_{CC}$  must be applied simultaneously or after  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ . obsolete

Figure 7. Margin mode AC waveforms



1. A8 High level = 5V; A9 High level = 12V.

Table 11. Programming mode AC characteristics

Symbol	Alt	Para male r	Test condition <sup>(1)(2)</sup>	Min	Max	Unit
t <sub>AVEL</sub>	t <sub>AS</sub>	Address valid to Chip Enable low		2		μs
t <sub>QVEL</sub>	t <sub>DS</sub>	Input Valio to Chip Enable low		2		μs
t <sub>VCHEL</sub>	t <sub>VCS</sub>	′ <sub>C நா</sub> ழ்h to Chip Enable low		2		μs
t <sub>VPHEL</sub>	toes	V <sub>PP</sub> high to Chip Enable low		2		μs
t <sub>VPLVF'</sub>	PRT	V <sub>PP</sub> rise time		50		ns
tsleh	t <sub>PW</sub>	Chip Enable program pulse width (Initial)		95	105	μs
t <sub>EHQX</sub>	t <sub>DH</sub>	Chip Enable high to input transition		2		μs
t <sub>EHVPX</sub>	t <sub>OEH</sub>	Chip Enable high to V <sub>PP</sub> transition		2		μs
t <sub>VPLEL</sub>	t <sub>VR</sub>	V <sub>PP</sub> low to Chip Enable low		2		μs
t <sub>ELQV</sub>	t <sub>DV</sub>	Chip Enable low to output valid			1	μs
t <sub>EHQZ</sub> (3)	t <sub>DFP</sub>	Chip Enable high to output Hi-Z		0	130	ns
t <sub>EHAX</sub>	t <sub>AH</sub>	Chip Enable high to address transition		0		ns

<sup>1.</sup>  $T_A = 25$  °C;  $V_{CC} = 6.25V \pm 0.25V$ ;  $V_{PP} = 12.75V \pm 0.25V$ 

<sup>2.</sup>  $V_{CC}$  must be applied simultaneously with or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ .

<sup>3.</sup> Sampled only, not 100% tested.

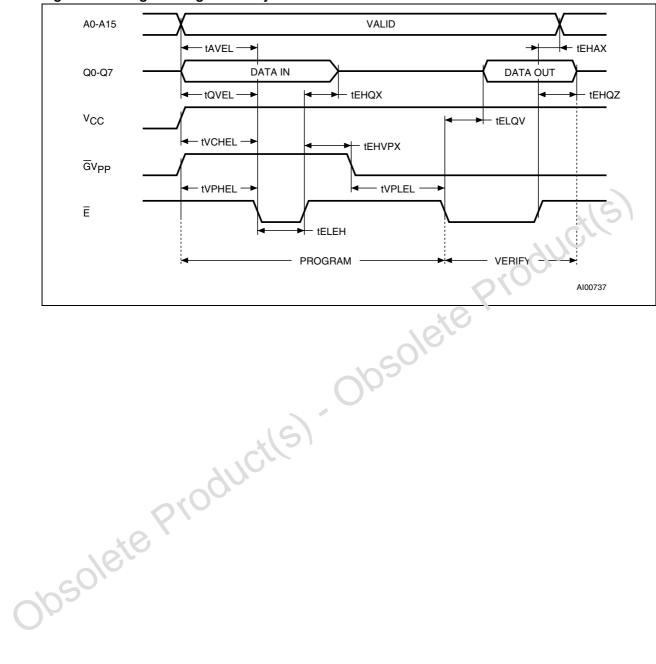


Figure 8. Programming and verify mode AC waveforms

## 5 Package mechanical data

In order to meet environmental requirements, ST offers the M27W512 in ECOPACK<sup>®</sup> packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at www.st.com.

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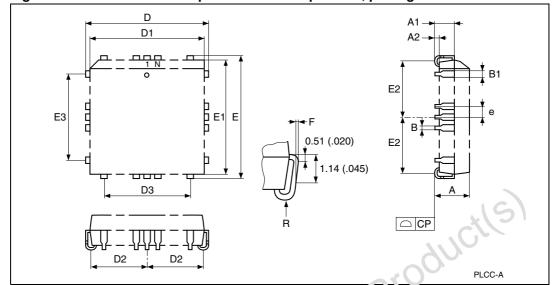


Figure 9. PLCC32 - 32 lead plastic leaded chip carrier, package outline

1. Drawing is not to scale.

Table 12. PLCC32 - 32 lead plastic leaded chip carrier, package mechanical data

	Symbol	millimeters			inches <sup>(1)</sup>			
	Symbol	Тур	Min	Max	Тур	Min	Max	
16	A		3.175	3.556		0.1250	0.1400	
	A1	5	1.530	2.413		0.0602	0.0950	
	A2	di	0.381	-		0.0150	-	
	В		0.330	0.533		0.0130	0.0210	
	B1		0.660	0.813		0.0260	0.0320	
	JF -			0.100			0.0039	
	D		12.319	12.573		0.4850	0.4950	
	D1		11.354	11.506		0.4470	0.4530	
anso"	D2		4.780	5.660		0.1882	0.2228	
002	D3	7.620	-	-	0.3000	-	-	
	E		14.859	15.113		0.5850	0.5950	
	E1		13.894	14.046		0.5470	0.5530	
	E2		6.050	6.930		0.2382	0.2728	
	E3	10.160	-	-	0.4000	-	-	
	е	1.270	-	-	0.0500	-	-	
	F		0.000	0.127		0.0000	0.0050	
	R	0.889	-	-	0.0350	-	-	
	N (number of pins)		32			32		

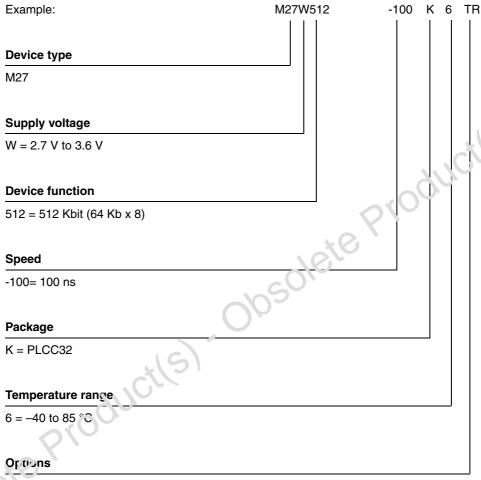
<sup>1.</sup> Values in inches are converted from mm and rounded to 4 decimal digits.

**5**//

Part numbering M27W512

# 6 Part numbering

Table 13. Ordering information scheme



Blank = Standard packing

TR = Tape and reel packing

For a list of available options (speed, package, etc.) or for further information on any aspect of this device, please contact your nearest ST sales office.

M27W512 Revision history

# 7 Revision history

Table 14. Document revision history

Date	ate Revision	Changes
20-Mar-2000	ar-2000 1.1	FDIP28W Package Dimension, L Max added ( <i>Table 12</i> ) TSOP32 Package Dimension changed ( <i>Table 13</i> ) 0 to 70°C Temperature Range deleted Speed Classes changed
15-Jun-2001	n-2001 1.2	Typing error ( <i>Table 8</i> )
30-Aug-2002	g-2002 1.3	Package mechanical data clarified for FDIP28W ( <i>Table 12</i> ), PL'P28 ( <i>Table 13</i> ), PLCC32 ( <i>Table 12</i> , <i>Figure 9</i> ) and TSOP28 ( <i>Table 13 Figure 11</i> )
08-Nov-2004	v-2004 2.0	Details of ECOPACK lead-free package options add a
27-Apr-2007	or-2007 3	Document reformatted.  FDIP28W and PDIP28 packages removed.  120, 150 and 200ns access times removed from <i>Table 13: Ordering information scheme</i> .
09-Jun-2008	n-2008 4	Small text changes. Living no longer offered (references to UV removed).  TSOP28 nack ago removed. Package mechanical data in inches calculated from millimeters and rounded to three decimals (see Table 12: PLCC32 - 32 lead plastic leaded chip carrier, package mechanical data).  E and F options and 80 ns speed class removed from Table 13: Ordering information scheme.
etePro	Skogine	

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